



Anti-surge thin film chip resistors

MRG series

AEC-Q200 Compliant

Features

- Significant improvement of anti-surge capability comparing to existing thin film resistors
- Precision resistance tolerance: $\pm 0.5\%$, very small TCR: $\pm 10\text{ppm}/^\circ\text{C}$
- Thin film structure enabling low noise and anti-sulfur

Applications

- Power source related devices
- Automotive electronics
- Robotics, Industrial control system

Part numbering system

MRG 2012 N - 104 - D - T5

Series code

Size: MRG2012, MRG3216, MRG5025

Temperature coefficient of resistance

Packaging quantity: T5(5,000pcs)
(MRG2012, MRG3216)
T4(4,000pcs) (MRG5025)

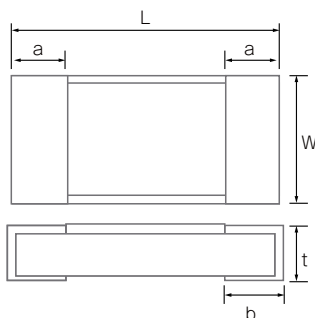
Resistance tolerance

Nominal resistance value
(E-24, E-96, MRG3216, MRG5025: all 4 digit)

Electrical Specification

Type	Power ratings	Temperature coefficient of resistance	Resistance range(Ω) Resistance tolerance	Maximum voltage	Resistance value series	Operating temperature	Packaging quantity
		(ppm/°C)	±0.5% (D)				
MRG2012	1/10W	±10(N)	100≤R≤1M	150V	E-24, E-96	-55℃ ~ 155℃	T5
		±25(P)					
MRG3216	1/8W	±10(N)	100≤R≤2M	200V			
		±25(P)					
MRG5025	1/2W	±10(N)	100≤R≤2M	300V			T4
		±25(P)					

Dimensions



Type	Size (inch)	L	W	a	b	t
MRG2012	0805	2.00 ± 0.20	$1.25 + 0.25 / - 0.20$	0.40 ± 0.20	0.40 ± 0.20	$0.40 + 0.15 / - 0.10$
MRG3216	1206	3.20 ± 0.20	1.60 ± 0.25	0.50 ± 0.25	0.50 ± 0.25	$0.40 + 0.15 / - 0.10$
MRG5025	2010	5.00 ± 0.20	2.50 ± 0.25	0.60 ± 0.25	0.60 ± 0.25	$0.45 + 0.15 / - 0.10$

(unit : mm)

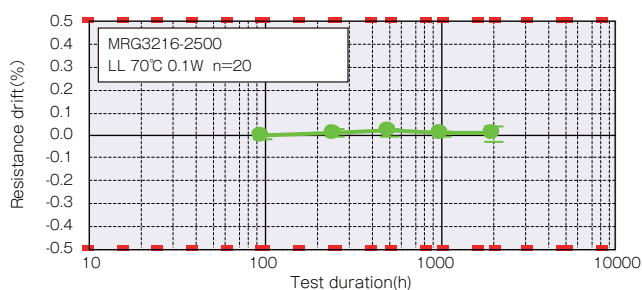
◆ Reliability specification

Test items	Condition (test methods (MIL-PRF-55342/JIS C5201-1))	Standard
Short time overload	2.5 x rated voltage, ^{*1} 5seconds	±(0.05%+0.01Ω)
Life (biased)	85°C, rated voltage, ^{*1} 90min on 30min off, 2000hours	±(0.25%+0.01Ω)
High temperature high humidity	85°C, 85%RH, 1/10 of rated power, 90min on 30min off, 2000hours	±(0.25%+0.01Ω)
Temperature shock	-55°C (30min) ~ 125°C (30min) 2000cycles	±(0.25%+0.01Ω)
High temperature exposure	155°C, no bias, 2000hours	±(0.5%+0.01Ω)
ESD (HBM)	4KV (Positive 3times, negative 3 times)	±(0.5%+0.05Ω)
Resistance to soldering heat	260±5°C, 10 seconds (reflow)	±(0.05%+0.01Ω)

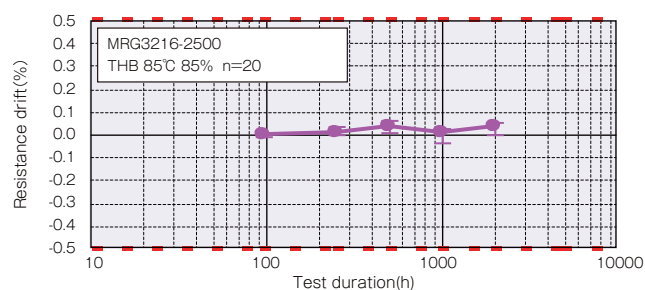
*1 Rated voltage is given by $E = \sqrt{R \times P}$ E= rated voltage (V), R=nominal resistance value(Ω), P=rated power(W)
If rated voltage exceeds maximum voltage /element, maximum voltage/element is the rated voltage.

◆ Reliability test data

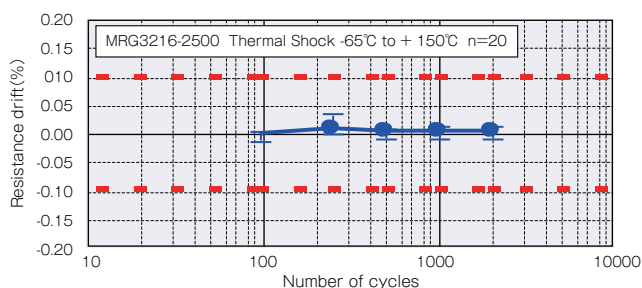
○ Biased life test



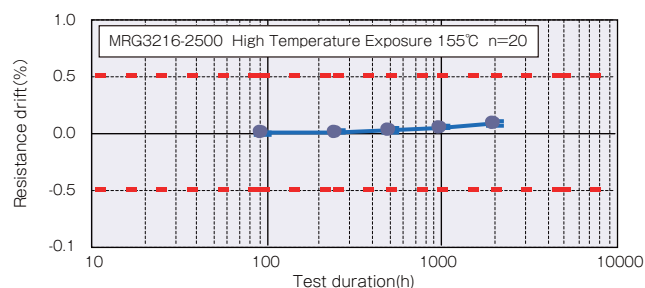
○ High temperature high humidity (biased)



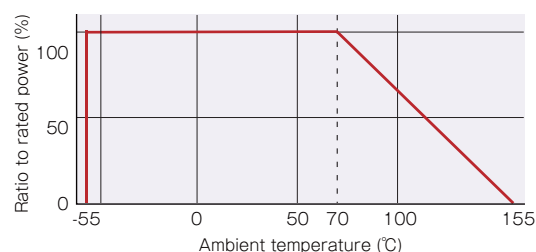
○ Temperature shock



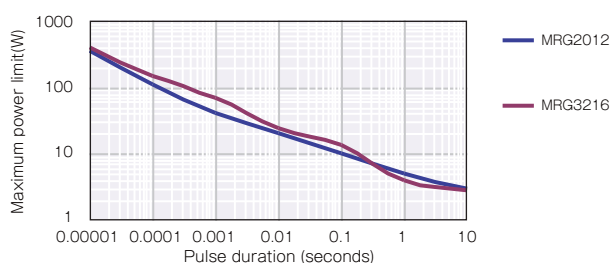
○ High temperature exposure



◆ Derating Curve



◆ Maximum pulse power limit (single pulse)



◆ Maximum pulse power limit (multiple pulses)

